

Notice of References Cited

Application/Control No.

09/311,952

Applicant(s)/Patent Under

Reexamination

MURAYAMA ET AL.

Examiner

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Art Unit

2142

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,935,205	08-1999	Murayama et al.	709/216
	B	US-			
	C	US-			
	D	US-			
	E	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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